Docket No.: SAA-002

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Nobukatsu NISHIDA et al.

U.S. Patent Application No. not yet assigned

Filed: herewith

For: METHOD, SYSTEM, AND APPARATUS FOR DETACHING AND COLLECTING AN IC TAG FROM A PAPER SHEET TO WHICH IT IS ATTACHED

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed with the application and no certification or fee is required.

Please note this is a PCT application in the entry of the National Phase in the U.S. and copies of the references cited were transmitted by WIPO and are believed to be in the file of the above-identified application and readily available to the Examiner. Therefore it is believed that Applicants have met all requirements regarding duty of disclosure under 37 CFR 1.56. A copy of the foreign search report is attached for the Examiner's information. Acknowledgement and consideration of these documents are respectfully requested.

Respectfully submitted,

HAUPTMAN KANESAKA BERNER Patent Agents, LLP

nneth W. Berner

Kenneth M. Berner Registration No. 37,093

1700 Diagonal Road, Suite 310 Alexandria, Virginia 22314 (703) 684-1111 KMB/iyr Facsimile: (703) 518-5499

Date: May 3, 2005

JC14 Rec'd PCT/PTO 03 MAY 2005

Sheet 1 of 1

ATTY. DOCKET NO. INFORMATION DISCLOSURE **SAA-002** APPLICANT CITATION IN AN Nobukatsu NISHIDA et al. APPLICATION FILING DATE **GROUP** herewith (PTO-1449) U.S. PATENT DOCUMENTS. 400 **FILING EXAMINER'S CLASS SUBCLASS** NAME DATE **INITIALS** PATENT NO. DATE FOREIGN PATENT DOCUMENTS 100 A-11 X Translation **EXAMINER'S SUBCLASS COUNTRY CLASS** DATE PATENT NO. **INITIALS** 01-17-2003 JP 2003-16415A JP 08-23-2002 2002-236889 9-38629A 02-10-1997 JP 10-27-1977 JP 52-125582A 2002-211755A 07-31-2002 JP JP 2001-334530A 12-04-2001 06-22-2001 JP 2001-167240 JP 01-10-2001 2001-14442 JP 2000-194820 07-14-2000 04-11-2003 JP 2003-108962 OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) DATE CONSIDERED **EXAMINER**

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.